



# 3.3V CMOS 3-LINE TO 8-LINE DECODER/DEMULTIPLEXER WITH 5 VOLT TOLERANT I/O

IDT74LVC138A

## FEATURES:

- 0.5 MICRON CMOS Technology
- ESD > 2000V per MIL-STD-883, Method 3015;  
> 200V using machine model (C = 200pF, R = 0)
- 1.27mm pitch SOIC, 0.635mm pitch QSOP,  
0.65mm pitch SSOP, 0.65mm pitch TSSOP packages
- Extended commercial range of -40°C to +85°C
- Vcc = 3.3V ±0.3V, Normal Range
- Vcc = 2.3V to 3.6V, Extended Range
- CMOS power levels (0.4µW typ. static)
- Rail-to-Rail output swing for increased noise margin
- All inputs, outputs and I/O are 5 Volt tolerant
- Supports hot insertion

## Drive Features for LVC138A:

- High Output Drivers: ±24mA
- Reduced system switching noise

## APPLICATIONS:

- 5V and 3.3V mixed voltage systems
- Data communication and telecommunication systems

## DESCRIPTION:

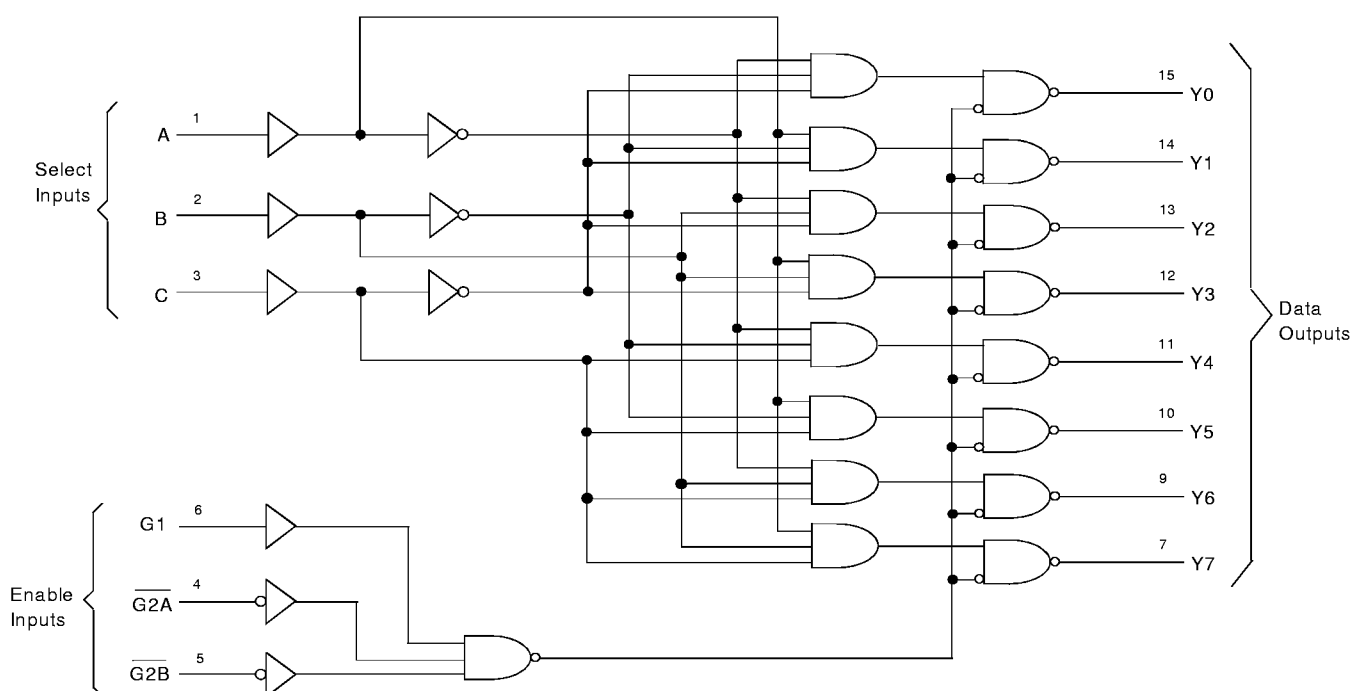
The LVC138A 3-line to 8-line decoder/demultiplexer is built using advanced dual metal CMOS technology. This device is designed for high-performance memory-decoding or data-routing applications requiring very short propagation delay times. In high performance memory systems, this decoder minimizes the effects of system decoding. When employed with high-speed memories utilizing a fast enable circuit, the delay times of these decoders and the enable time of the memory are usually less than the typical access time of the memory. This means that the effective system delay introduced by the decoder is negligible.

The conditions at the binary-select inputs and the three enable inputs select one of eight output lines. Two active-low enable inputs and one active-high enable input reduce the need for external gates or inverters when expanding. A 24-line decoder can be implemented without external inverters and a 32-line decoder requires only one inverter. An enable input can be used as a data input for demultiplexing applications.

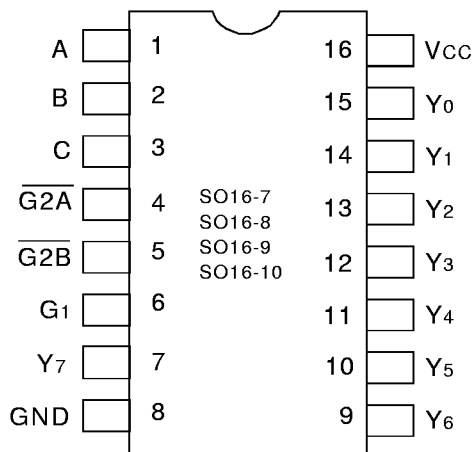
Inputs can be driven from either 3.3V or 5V devices. This feature allows the use of this device as a translator in a mixed 3.3V/5V supply system.

The LVC138A has been designed with a ±24mA output driver. This driver is capable of driving a moderate to heavy load while maintaining speed performance.

## FUNCTIONAL BLOCK DIAGRAM



### PIN CONFIGURATION



SOIC/SSOP/TSSOP/QSOP  
TOP VIEW

### ABSOLUTE MAXIMUM RATINGS (1)

Symbol	Description	Max.	Unit
VTERM(2)	Terminal Voltage with Respect to GND	-0.5 to +6.5	V
VTERM(3)	Terminal Voltage with Respect to GND	-0.5 to +6.5	V
TSTG	Storage Temperature	-65 to +150	°C
I <sub>OUT</sub>	DC Output Current	-50 to +50	mA
I <sub>IK</sub>	Continuous Clamp Current, V <sub>I</sub> < 0 or V <sub>O</sub> < 0	-50	mA
I <sub>CC</sub>	Continuous Current through each V <sub>CC</sub> or GND	±100	mA

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#### NOTES:

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- V<sub>CC</sub> terminals.
- All terminals except V<sub>CC</sub>.

### PIN DESCRIPTION

Pin Names	Description
G1	Input Enable
$\overline{G2A}$ , $\overline{G2B}$	Input Enables (Active LOW)
Y <sub>x</sub>	Data Outputs
A, B, C	Select Data Inputs

### CAPACITANCE (T<sub>A</sub> = +25°C, f = 1.0MHz)

Symbol	Parameter(1)	Conditions	Typ.	Max.	Unit
C <sub>IN</sub>	Input Capacitance	V <sub>IN</sub> = 0V	4.5	6	pF
C <sub>OUT</sub>	Output Capacitance	V <sub>OUT</sub> = 0V	5.5	8	pF
C <sub>I/O</sub>	I/O Port Capacitance	V <sub>IN</sub> = 0V	6.5	8	pF

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#### NOTE:

- As applicable to the device type.

### FUNCTION TABLE (1)

Enable Inputs			Select Inputs			Outputs							
G1	$\overline{G2A}$	$\overline{G2B}$	C	B	A	Y0	Y1	Y2	Y3	Y4	Y5	Y6	Y7
X	H	X	X	X	X	H	H	H	H	H	H	H	H
X	X	H	X	X	X	H	H	H	H	H	H	H	H
L	X	X	X	X	X	H	H	H	H	H	H	H	H
H	L	L	L	L	L	L	H	H	H	H	H	H	H
H	L	L	L	L	H	H	L	H	H	H	H	H	H
H	L	L	L	H	L	H	H	L	H	H	H	H	H
H	L	L	L	H	H	H	H	H	L	H	H	H	H
H	L	L	H	L	L	H	H	H	H	L	H	H	H
H	L	L	H	L	H	H	H	H	H	H	L	H	H
H	L	L	H	H	L	H	H	H	H	H	H	L	H
H	L	L	H	H	H	H	H	H	H	H	H	H	L

#### NOTE:

- H = HIGH Voltage Level  
L = LOW Voltage Level  
X = Don't Care

## DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified:

Operating Condition:  $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$

Symbol	Parameter	Test Conditions		Min.	Typ. <sup>(1)</sup>	Max.	Unit
V <sub>IH</sub>	Input HIGH Voltage Level	V <sub>CC</sub> = 2.3V to 2.7V		1.7	—	—	V
		V <sub>CC</sub> = 2.7V to 3.6V		2	—	—	
V <sub>IL</sub>	Input LOW Voltage Level	V <sub>CC</sub> = 2.3V to 2.7V		—	—	0.7	V
		V <sub>CC</sub> = 2.7V to 3.6V		—	—	0.8	
I <sub>IH</sub> I <sub>IL</sub>	Input Leakage Current	V <sub>CC</sub> = 3.6V	V <sub>I</sub> = 0 to 5.5V	—	—	±5	μA
I <sub>OZH</sub> I <sub>OZL</sub>	High Impedance Output Current (3-State Output pins)	V <sub>CC</sub> = 3.6V	V <sub>O</sub> = 0 to 5.5V	—	—	±10	μA
I <sub>OFF</sub>	Input/Output Power Off Leakage	V <sub>CC</sub> = 0V, V <sub>IN</sub> or V <sub>O</sub> ≤ 5.5V		—	—	±50	μA
V <sub>IK</sub>	Clamp Diode Voltage	V <sub>CC</sub> = 2.3V, I <sub>IN</sub> = -18mA		—	-0.7	-1.2	V
V <sub>H</sub>	Input Hysteresis	V <sub>CC</sub> = 3.3V		—	100	—	mV
I <sub>CC1</sub> I <sub>CCH</sub> I <sub>CCZ</sub>	Quiescent Power Supply Current	V <sub>CC</sub> = 3.6V	V <sub>IN</sub> = GND or V <sub>CC</sub>	—	—	10	μA
ΔI <sub>CC</sub>	Quiescent Power Supply Current Variation	One input at V <sub>CC</sub> - 0.6V other inputs at V <sub>CC</sub> or GND		—	—	500	μA

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### NOTE:

1. Typical values are at V<sub>CC</sub> = 3.3V, +25°C ambient.

## OUTPUT DRIVE CHARACTERISTICS

Symbol	Parameter	Test Conditions <sup>(1)</sup>		Min.	Max.	Unit
V <sub>OH</sub>	Output HIGH Voltage	V <sub>CC</sub> = 2.3V to 3.6V	I <sub>OH</sub> = -0.1mA	V <sub>CC</sub> - 0.2	—	V
		V <sub>CC</sub> = 2.3V	I <sub>OH</sub> = -6mA	2	—	
		V <sub>CC</sub> = 2.3V	I <sub>OH</sub> = -12mA	1.7	—	
		V <sub>CC</sub> = 2.7V		2.2	—	
		V <sub>CC</sub> = 3.0V		2.4	—	
		V <sub>CC</sub> = 3.0V	I <sub>OH</sub> = -24mA	2.2	—	
V <sub>OL</sub>	Output LOW Voltage	V <sub>CC</sub> = 2.3V to 3.6V	I <sub>OL</sub> = 0.1mA	—	0.2	V
		V <sub>CC</sub> = 2.3V	I <sub>OL</sub> = 6mA	—	0.4	
			I <sub>OL</sub> = 12mA	—	0.7	
		V <sub>CC</sub> = 2.7V	I <sub>OL</sub> = 12mA	—	0.4	
		V <sub>CC</sub> = 3.0V	I <sub>OL</sub> = 24mA	—	0.55	

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### NOTE:

1. V<sub>IH</sub> and V<sub>IL</sub> must be within the min. or max. range shown in the DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE table for the appropriate V<sub>CC</sub> range. T<sub>A</sub> = -40°C to +85°C.

**OPERATING CHARACTERISTICS, T<sub>A</sub> = 25°C**

Symbol	Parameter	Test Conditions	V <sub>CC</sub> = 2.5V±0.2V	V <sub>CC</sub> = 3.3V±0.3V	Unit
			Typical	Typical	
CPD	Power Dissipation Capacitance	C <sub>L</sub> = 0pF, f = 10Mhz	—	27	pF

**SWITCHING CHARACTERISTICS (1)**

Symbol	Parameter	V <sub>CC</sub> = 2.5V±0.2V		V <sub>CC</sub> = 2.7V		V <sub>CC</sub> = 3.3V±0.3V		Unit
				Min.	Max.	Min.	Max.	
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay A to B, C to Y <sub>x</sub>	—	—	—	7.9	1	6.7	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay $\overline{G2A}$ or $\overline{G2B}$ to Y <sub>x</sub>	—	—	—	7.4	1	6.5	ns
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay G1 to Y <sub>x</sub>	—	—	—	6.4	1	5.8	ns
t <sub>SU</sub>	Setup Time, at A, B, and C before G	2.4	—	2.5	—	2.3	—	ns
t <sub>H</sub>	Hold Time, at A, B, and C after G	1.6	—	1.5	—	1.5	—	ns
t <sub>SK(0)</sub>	Output Skew <sup>(2)</sup>	—	—	—	—	—	1	ns

**NOTES:**

1. See test circuits and waveforms. T<sub>A</sub> = - 40°C to + 85°C.
2. Skew between any two outputs of the same package and switching in the same direction.

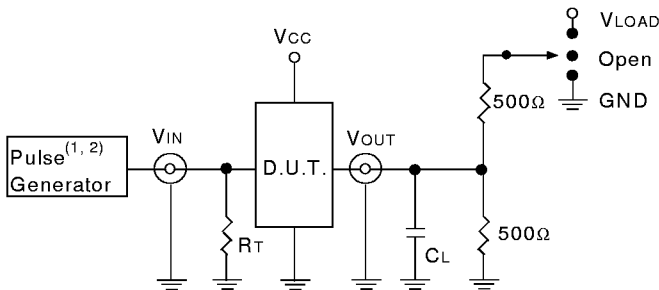
**TEST CIRCUITS AND WAVEFORMS**

**TEST CONDITIONS**

Symbol	V <sub>CC</sub> (1)= 2.5V ±0.2V	V <sub>CC</sub> (2)= 3.3V ±0.3V & 2.7V	Unit
V <sub>LOAD</sub>	2 x V <sub>CC</sub>	6	V
V <sub>IH</sub>	V <sub>CC</sub>	2.7	V
V <sub>T</sub>	V <sub>CC</sub> / 2	1.5	V
V <sub>LZ</sub>	150	300	mV
V <sub>HZ</sub>	150	300	mV
C <sub>L</sub>	30	50	pF

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**TEST CIRCUITS FOR ALL OUTPUTS**



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**DEFINITIONS:**

C<sub>L</sub> = Load capacitance: includes jig and probe capacitance.  
 R<sub>T</sub> = Termination resistance: should be equal to Z<sub>OUT</sub> of the Pulse Generator.

**NOTES:**

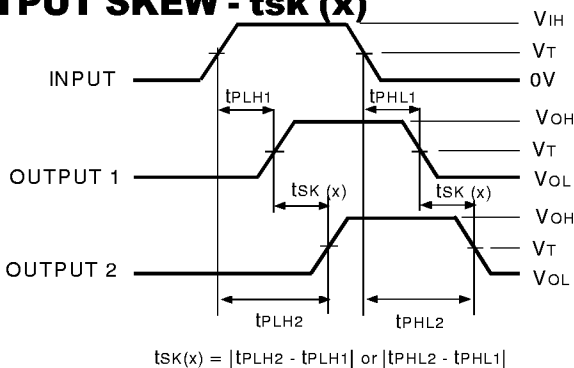
1. Pulse Generator for All Pulses: Rate ≤ 10MHz; t<sub>F</sub> ≤ 2ns; t<sub>R</sub> ≤ 2ns.
2. Pulse Generator for All Pulses: Rate ≤ 10MHz; t<sub>F</sub> ≤ 2.5ns; t<sub>R</sub> ≤ 2.5ns.

**SWITCH POSITION**

Test	Switch
Open Drain Disable Low Enable Low	V <sub>LOAD</sub>
Disable High Enable High	GND
All Other tests	Open

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**OUTPUT SKEW - t<sub>SK</sub>(x)**



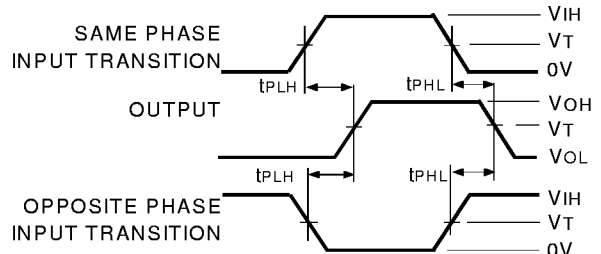
$$t_{SK}(x) = |t_{PLH2} - t_{PLH1}| \text{ or } |t_{PHL2} - t_{PHL1}|$$

**NOTES:**

1. For t<sub>SK</sub>(a) OUTPUT1 and OUTPUT2 are any two outputs.
2. For t<sub>SK</sub>(b) OUTPUT1 and OUTPUT2 are in the same bank.

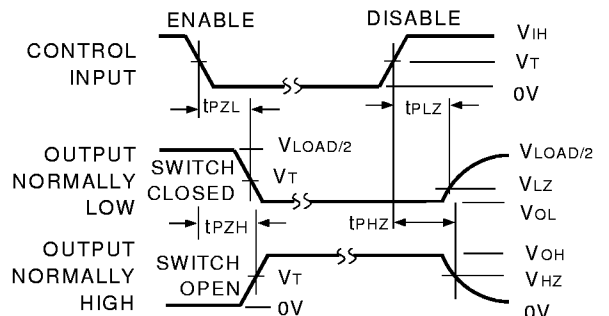
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**PROPAGATION DELAY**



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**ENABLE AND DISABLE TIMES**

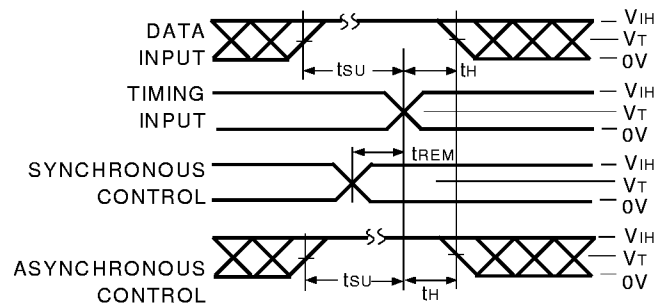


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**NOTE:**

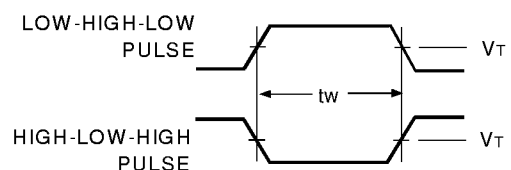
1. Diagram shown for input Control Enable-LOW and input Control Disable-HIGH.

**SET-UP, HOLD, AND RELEASE TIMES**



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**PULSE WIDTH**



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## ORDERING INFORMATION

IDT	XX	LVC	XXXX	XX	
Temp. Range			Device Type	Package	
				Q	Quarter Size Outline Package (SO16-7)
				DC	Small Outline IC (SO16-8)
				PY	Shrink Small Outline Package (SO16-9)
				PG	Thin Shrink Small Outline Package (SO16-10)
			138A		3-Line to 8-Line Decoder/Demultiplexer, $\pm 24\text{mA}$
				74	-40°C to +85°C



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